

Single N-channel MOSFET

ELM14440AA-N

■General description

ELM14440AA-N uses advanced trench technology to provide excellent $R_{ds(on)}$, low gate charge and low gate resistance.

■Features

- $V_{ds}=60V$
- $I_d=5A$ ($V_{gs}=10V$)
- $R_{ds(on)} < 55m\Omega$ ($V_{gs}=10V$)
- $R_{ds(on)} < 75m\Omega$ ($V_{gs}=4.5V$)

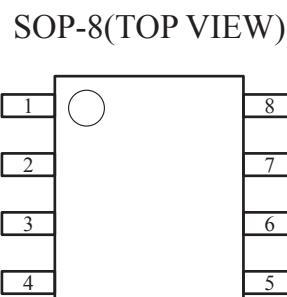
■Maximum absolute ratings

Parameter	Symbol	Limit	Unit	Note
Drain-source voltage	V_{ds}	60	V	
Gate-source voltage	V_{gs}	± 20	V	
Continuous drain current	I_d	5	A	1
		4		
Pulsed drain current	I_{dm}	20	A	2
Power dissipation	P_d	2.5	W	
		1.6		
Junction and storage temperature range	T_j, T_{stg}	-55 to 150	°C	

■Thermal characteristics

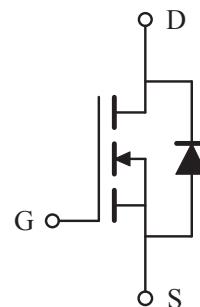
Parameter		Symbol	Typ.	Max.	Unit	Note
Maximum junction-to-ambient	$t \leq 10s$	$R_{\theta ja}$	38	50	°C/W	1
Maximum junction-to-ambient	Steady-state		69	80	°C/W	
Maximum junction-to-lead	Steady-state	$R_{\theta jl}$	24	30	°C/W	3

■Pin configuration



Pin No.	Pin name
1	SOURCE
2	SOURCE
3	SOURCE
4	GATE
5	DRAIN
6	DRAIN
7	DRAIN
8	DRAIN

■Circuit



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■Electrical characteristics

$T_a=25^\circ C$

Parameter	Symbol	Condition		Min.	Typ.	Max.	Unit	
STATIC PARAMETERS								
Drain-source breakdown voltage	BV _{dss}	Id=250μA, V _{gs} =0V		60			V	
Zero gate voltage drain current	Id _{ss}	V _{ds} =48V	T _j =55°C		1		μA	
		V _{gs} =0V			5			
Gate-body leakage current	I _{gss}	V _{ds} =0V, V _{gs} =±20V				100	nA	
Gate threshold voltage	V _{gs(th)}	V _{ds} =V _{gs} , Id=250μA		1.0	2.3	3.0	V	
On state drain current	Id(on)	V _{gs} =10V, V _{ds} =5V		20			A	
Static drain-source on-resistance	R _{ds(on)}	V _{gs} =10V	T _j =125°C		42	55	mΩ	
		Id=5A			75			
		V _{gs} =4.5V, Id=4A			54	75	mΩ	
Forward transconductance	G _{fs}	V _{ds} =5V, Id=5A			11		S	
Diode forward voltage	V _{sd}	Is=1A, V _{gs} =0V			0.78	1.00	V	
Max. body-diode continuous current	I _s					4	A	
DYNAMIC PARAMETERS								
Input capacitance	C _{iss}	V _{gs} =0V, V _{ds} =30V, f=1MHz			450	540	pF	
Output capacitance	C _{oss}				60		pF	
Reverse transfer capacitance	C _{rss}				25		pF	
Gate resistance	R _g	V _{gs} =0V, V _{ds} =0V, f=1MHz			1.65	2.00	Ω	
SWITCHING PARAMETERS								
Total gate charge (10V)	Q _g	V _{gs} =10V, V _{ds} =30V, Id=5A			8.5	10.5	nC	
Total gate charge (4.5V)	Q _g				4.3	5.5	nC	
Gate-source charge	Q _{gs}				1.6		nC	
Gate-drain charge	Q _{gd}				2.2		nC	
Turn-on delay time	t _{d(on)}	V _{gs} =10V, V _{ds} =30V R _l =6Ω, R _{gen} =3Ω			5.1	7.0	ns	
Turn-on rise time	t _r				2.6	4.0	ns	
Turn-off delay time	t _{d(off)}				15.9	20.0	ns	
Turn-off fall time	t _f				2.0	3.0	ns	
Body diode reverse recovery time	t _{rr}	I _f =5A, dI/dt=100A/μs			25.1	35.0	ns	
Body diode reverse recovery charge	Q _{rr}	I _f =5A, dI/dt=100A/μs			28.7		nC	

NOTE :

1. The value of $R_{θja}$ is measured with the device mounted on 1in² FR-4 board of 2oz. Copper, in still air environment with $T_a=25^\circ C$. The value in any given applications depends on the user's specific board design. The current rating is based on the $t \leq 10s$ thermal resistance rating.
2. Repetitive rating, pulse width limited by junction temperature.
3. The $R_{θja}$ is the sum of the thermal impedance from junction to lead $R_{θjl}$ and lead to ambient.
4. The static characteristics in Figures 1 to 6 are obtained using 80μs pulses, duty cycle 0.5%max.
5. These tests are performed with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_a=25^\circ C$. The SOA curve provides a single pulse rating.



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■ Typical electrical and thermal characteristics

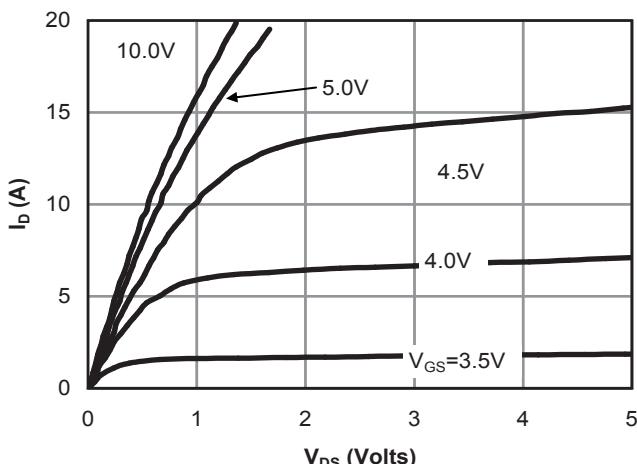


Fig 1: On-Region Characteristics

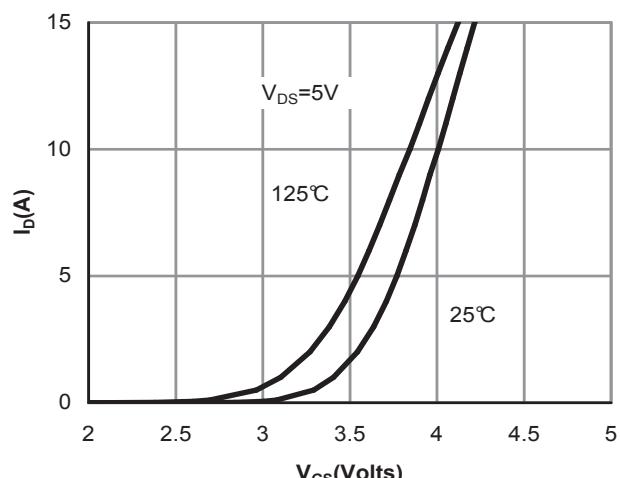


Figure 2: Transfer Characteristics

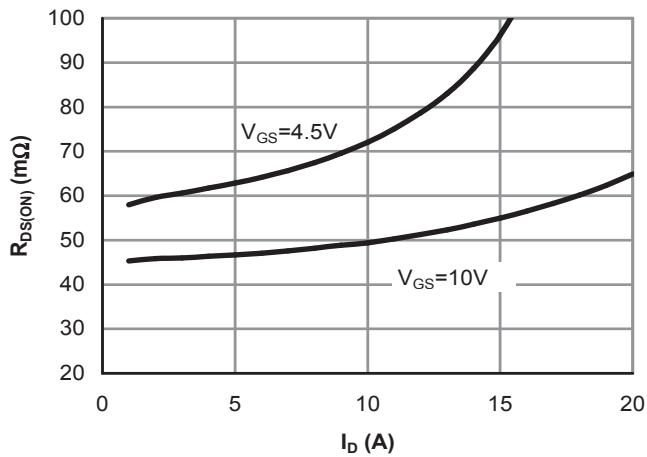


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

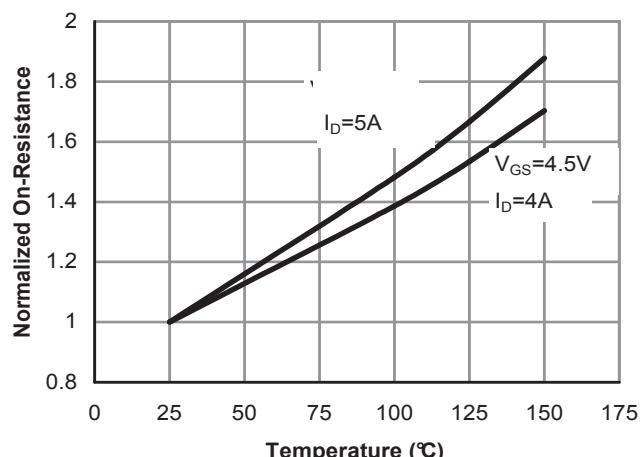


Figure 4: On-Resistance vs. Junction Temperature

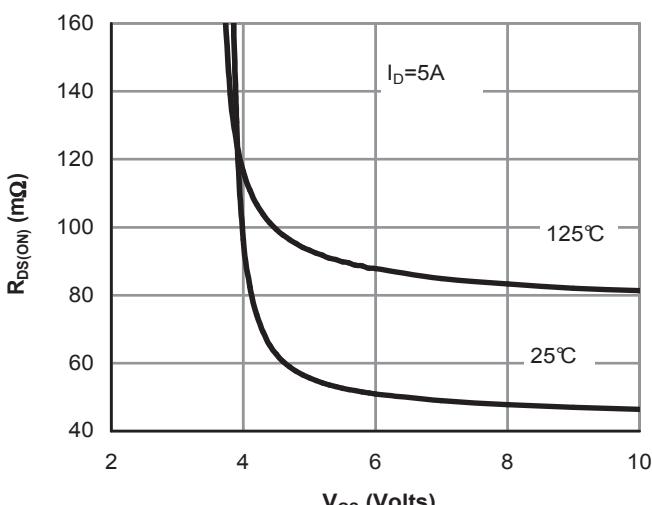


Figure 5: On-Resistance vs. Gate-Source Voltage

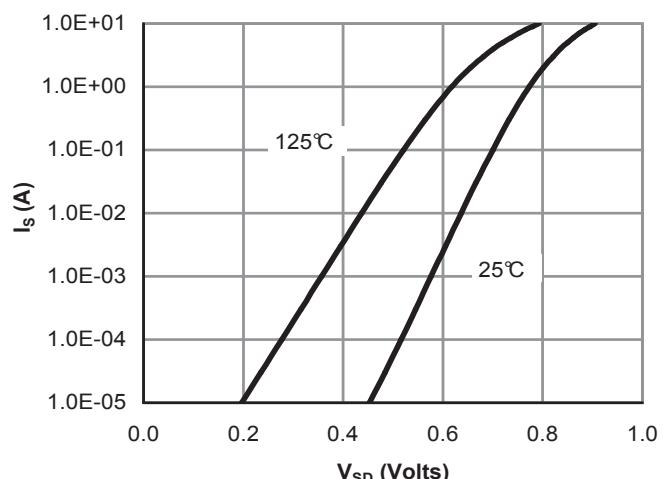


Figure 6: Body-Diode Characteristics

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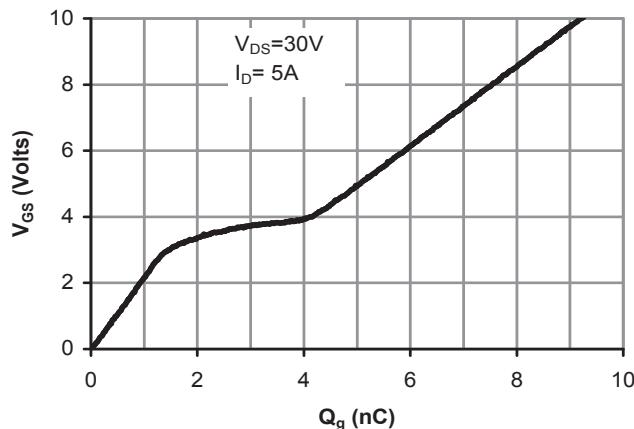


Figure 7: Gate-Charge Characteristics

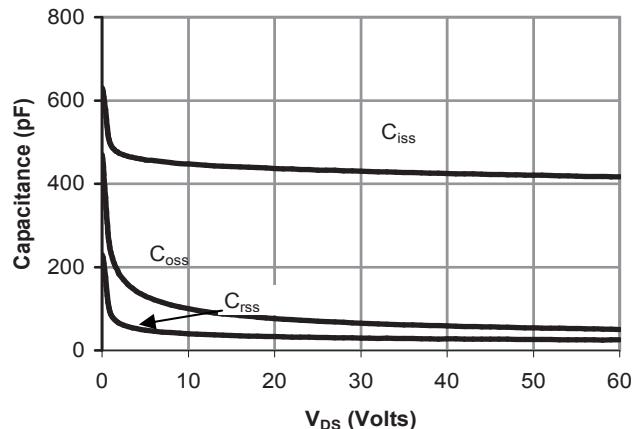


Figure 8: Capacitance Characteristics

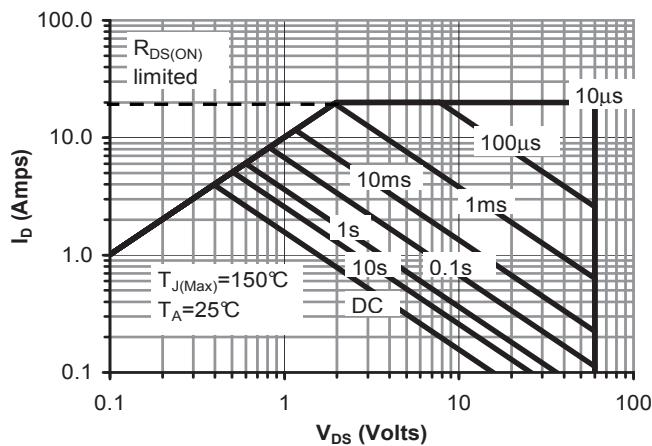


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

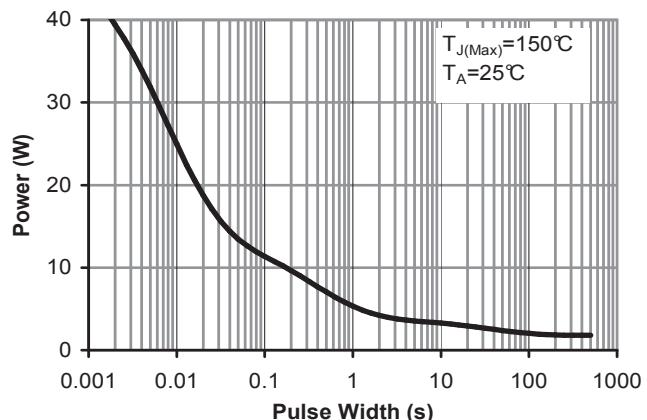


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

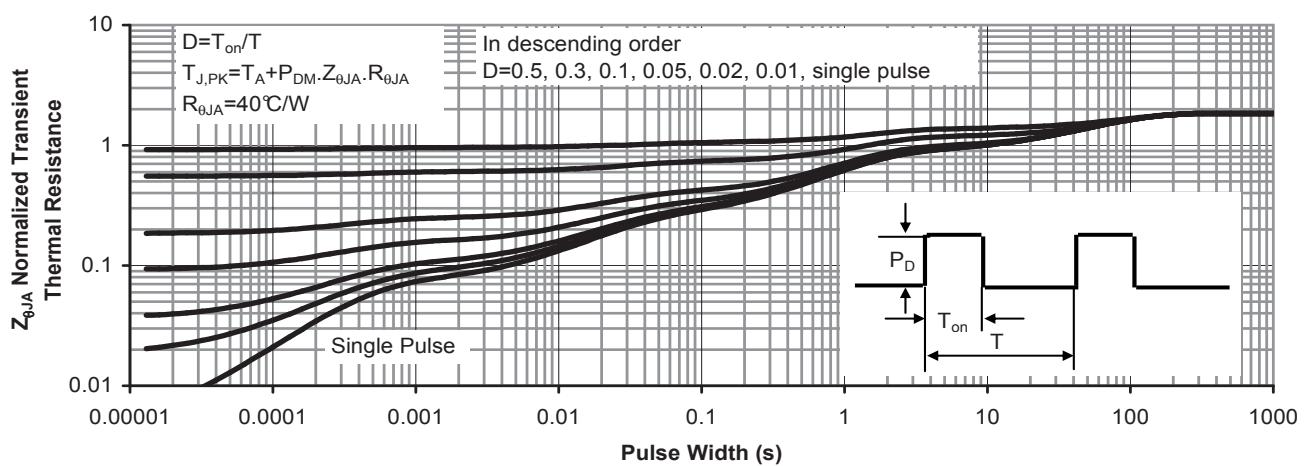


Figure 11: Normalized Maximum Transient Thermal Impedance